ABSTRACT
The DRV3205-Q1 device features a highly configurable watchdog timer used to monitor an external microcontroller unit (MCU). This application report describes the functionality of the DRV3205-Q1 watchdog timer.

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1 Watchdog Timer Overview
A typical system implementation for the DRV3205-Q1, as shown in Figure 1, includes a microcontroller unit (MCU) that controls the three phases of the gate driver and communicates over serial peripheral interface (SPI).

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Figure 1. Typical Application Diagram
In this type of application, a failure in the MCU can have a catastrophic impact on the system. To help prevent further damage to the system, the DRV3205-Q1 device can be configured to monitor the health of the MCU using a watchdog timer. By periodically checking the MCU, the DRV3205-Q1 device can shut down the external MOSFETs and bring the system to a safe state.

1.1 **Watchdog Operation**

The question and answer watchdog operates on a periodic basis by sending specific message sequences through SPI. Upon the request from the MCU, the DRV3205-Q1 device provides a token (or question) to the MCU over SPI, latched in the WDT_TOKEN_VALUE register. The MCU performs a fixed series of arithmetic operations on the token value and returns the resulting token value answers to the ASIC over SPI by writing to the WDT_ANSWER register. The DRV3205-Q1 device verifies that the MCU returns the token-value results (answers) within the specified timing windows, and that the token value responses (answers) are correct.

When the MCU performs the watchdog-related SPI communications within the correct timing windows, and returns the correctly calculated responses (answers), the watchdog considers these *good events*.

When the MCU performs the watchdog-related SPI communications outside of the correct timing windows, or returns an incorrectly calculated token response (answers), or returns the correct answers in the wrong sequence, the watchdog considers these *bad events*.

When the MCU suspends watchdog-related SPI communications for the duration of the watchdog-timeout window, the watchdog considers this as a *no response event*.

An internal counter stores the number of bad responses in the WD_FAIL_CNT register, which triggers a failure if the WD_FAIL_CNT reaches a predefined limit. By specifying the limit in the WD_FAIL_MAX register, a buffer for the number of bad events can be set.

![Figure 2. Simplified Watchdog-Timer Flow Chart](image-url)
1.2 Timing Windows
The timing of the four responses is synchronized in two internal time windows. The first three responses must be sent during the first timing window (open window), configured in the RT field of the WDT_WIN1_CFG register. The last response must be sent during the second timing window (close window). The close window expires either after the programmed time, configured by the RW field of the WDT_WIN2_CFG register, or after the next clock cycle following the final response.

For detailed information, refer to the DRV3205-Q1 Three-Phase Automotive Gate Driver With Three Integrated Current Shunt Amplifiers and Enhanced Protection, Diagnostics, and Monitoring.

1.3 Response Events

1.3.1 Good Event
A good event occurs when the answers are sent in the correct order and within the correct timing windows. After a good event, the watchdog failure counter (WD_FAIL_CNT) decrements and a new token is generated by the DRV3205-Q1 device and the process restarts. The example in Figure 1 shows the value of the DRV3205-Q1 registers after each watchdog response.

1.3.2 Bad Event
A bad event occurs when the MCU executes the watchdog sequence incorrectly. After any bad event, the DRV3205-Q1 device increases the watchdog fail count (WD_FAIL_CNT), and the token for the next frame remains the same. If the WD_FAIL_CNT counter exceeds the WD_FAIL_MAX value, the configured error condition is executed.

1.3.2.1 Incorrect Answer Value
An incorrect value written to the WDT_ANSWER register for one of the responses generates a token error and sequence error. The token error remains active until the next response is given and the sequence error remains set until the next correct sequence is executed.

Figure 3. Watchdog-Timer Good Event
1.3.2.2 Incorrect Answer Sequence

If a received token response is in the wrong order, the DRV3205-Q1 device responds similarly to the incorrect answer value case, except the token-error flag (TOKEN_ERR) remains set for every response that is out of order.

1.3.2.3 Out-of-Timing Window

Several possible response cases can result in responses being sent out of the correct window. These cases are as follows:

- Early response sent during the close window
- Fourth response in the open window
- Response received after the transaction
In the case that the fourth response is received in the open window, the DRV3205-Q1 device generates a token-early flag (TOKEN_EARLY), which is not cleared until the next good response event.

![Figure 6. Out-of-Timing Window Timing Diagram](image)

### 1.3.3 No Response Event

A no response event occurs if the MCU suspends the watchdog-related SPI communications for the duration of the watchdog window. During this event the TIME_OUT flag is set. This flag can be used by the MCU software to resynchronize the watchdog events on the required watchdog timing.

![Figure 7. WDT No Response Event](image)

### 1.4 Token Generation

The watchdog timer uses a linear-feedback shift-register (LFSR) circuit to generate a cyclic series of token values. The LFSR equation is set by default, and generates a total of 15 values for each cycle. The initial value (seed) of this LFSR is preloaded to a default value, and is set to a new value after every LFSR cycle.

After each good event, a four-bit internal WDT TOKEN counter is incremented. The combination of this counter value and the LFSR output is used to create the token value. When the WDT TOKEN counter overflows, the seed value is shifted based on the LFSR equation.
2 Implementing the Watchdog Timer

2.1 Initial Configuration

The default state of the DRV3205-Q1 device upon reset is with the watchdog timer disabled (WD_EN = 0). The watchdog timer must be configured and enabled in the DIAGNOSTIC state, as the registers become locked in the ACTIVE state. Table 1 lists summary of all watchdog-setting bit fields as a reference.

<table>
<thead>
<tr>
<th>Bit Field Name</th>
<th>Register</th>
<th>Address</th>
<th>Bits</th>
<th>Descriptions</th>
<th>Type</th>
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<tbody>
<tr>
<td>RT[6:0]</td>
<td>WDT_WIN1_CFG</td>
<td>0x31</td>
<td>[7:1]</td>
<td>Open window: 0.55 ms × (1 + setting)</td>
<td>Config</td>
</tr>
<tr>
<td>RW[4:0]</td>
<td>WDT_WIN2_CFG</td>
<td>0x32</td>
<td>[7:3]</td>
<td>Close window: 0.55 ms × (1 + setting)</td>
<td>Config</td>
</tr>
<tr>
<td>FDBK[3:0]</td>
<td>WDT_TOKEN_FD</td>
<td>0x33</td>
<td>[7:4]</td>
<td>Adjust token feedback</td>
<td>Config</td>
</tr>
<tr>
<td>TOKEN_SEED[3:0]</td>
<td>WDT_TOKEN_FD</td>
<td>0x33</td>
<td>[3:0]</td>
<td>Change token seed</td>
<td>Config</td>
</tr>
<tr>
<td>TOKEN[3:0]</td>
<td>WDT_TOKEN</td>
<td>0x34</td>
<td>[6:3]</td>
<td>Token value</td>
<td>Operation</td>
</tr>
<tr>
<td>WDT_ANSW[7:0]</td>
<td>WDT_ANSWER</td>
<td>0x35</td>
<td>[7:0]</td>
<td>Answer register</td>
<td>Operation</td>
</tr>
<tr>
<td>WD_RST_EN</td>
<td>SFCR1</td>
<td>0x09</td>
<td>[6]</td>
<td>Enable transition to RESET state after WD fail</td>
<td>Config</td>
</tr>
<tr>
<td>WD_EN</td>
<td>SFCR1</td>
<td>0x09</td>
<td>[0]</td>
<td>Enable the WDT</td>
<td>Config</td>
</tr>
<tr>
<td>WD_FAIL</td>
<td>STAT0</td>
<td>0x0A</td>
<td>[7]</td>
<td>WD_FAIL_CNT ≥ WD_FAIL_MAX</td>
<td>Status</td>
</tr>
<tr>
<td>WD_FAIL_CNT</td>
<td>STAT3</td>
<td>0x0C</td>
<td>[2:0]</td>
<td>Number of failed WDT operations</td>
<td>Status</td>
</tr>
<tr>
<td>NO_WRST</td>
<td>SFCC1</td>
<td>0x20</td>
<td>[6]</td>
<td>Disable transition to SAFE on WD_FAIL</td>
<td>Config</td>
</tr>
<tr>
<td>WDT_ANSW_CNT[1:0]</td>
<td>WDT_STATUS</td>
<td>0x36</td>
<td>[7:6]</td>
<td>Current answer received by the device</td>
<td>Status</td>
</tr>
<tr>
<td>TOKEN_ERR</td>
<td>WDT_STATUS</td>
<td>0x36</td>
<td>[5]</td>
<td>Invalid response</td>
<td>Status</td>
</tr>
<tr>
<td>SEQ_ERR</td>
<td>WDT_STATUS</td>
<td>0x36</td>
<td>[2]</td>
<td>Correct response in the wrong order</td>
<td>Status</td>
</tr>
<tr>
<td>TIME_OUT</td>
<td>WDT_STATUS</td>
<td>0x36</td>
<td>[1]</td>
<td>No response in the required window</td>
<td>Status</td>
</tr>
<tr>
<td>TOKEN_EARLY</td>
<td>WDT_STATUS</td>
<td>0x36</td>
<td>[0]</td>
<td>Final response in the first window</td>
<td>Status</td>
</tr>
<tr>
<td>WD_FAIL_MAX[2:0]</td>
<td>WD_FAIL_CFG</td>
<td>0x37</td>
<td>[7:5]</td>
<td>Max WD_FAIL_CNT to cause a fault</td>
<td>Config</td>
</tr>
<tr>
<td>WD_FAIL_DEFAULT[2:0]</td>
<td>WD_FAIL_CFG</td>
<td>0x37</td>
<td>[4:2]</td>
<td>Value to set WD_FAIL_CNT on transition from DIAG to ACTIVE</td>
<td>Config</td>
</tr>
</tbody>
</table>

To configure the device after reset, use the steps that follow:

1. Verify the device is in the DIAGNOSTIC state (ERR pin transitions from L to H).
2. Set the WDT_WIN1_CFG and WDT_WIN2_CFG registers for the desired open and closed window timings.
3. Set the WD_FAIL_MAX to the max fault tolerance allowed before error handling takes place. The maximum time to detect a fault is equal to Equation 1.

\[WD\_FAIL\_MAX \times ((RT[6:0] + 1) + (RW[4:0] + 1)) \times 0.55 \text{ ms} \] \hspace{1cm} (1)

4. Change the token seed and feedback values if a different Q/A configuration is needed.
5. Set the WD_EN bit to 1 to enable the watchdog timer. Use this operation to synchronize the MCU with the internal watchdog clock.

6. Verify that the WD_FAIL_CNT counter is decremented and the following error flags are clear:
   - TIME_OUT
   - TOKEN_ERR
   - SEQ_ERR
   - TOKEN_EARLY

7. Set the desired error handling (listed as follows) in case of watchdog timer fault:
   - WD_RST_EN causes the device to transition to the RESET state in case of a fault.
   - NO_WRST causes the device to not transition out of the ACTIVE state in case of a fault. This error handling has higher priority than WD_RST_EN and is typically used for debugging.

8. Clear the WD_FAIL bit to 0 if it is set to 1.

2.1.1 Disabling the Watchdog

The watchdog timer is disabled by default, and can only be disabled in the DIAGNOSTIC state. When using the DRV3205-Q1 device without the watchdog timer, the WD_FAIL_DEFAULT[2:0] bit must be set to a higher value than the default of 3 to allow full state transitions according to the device data sheet.

When the device is in the DIAGNOSTIC state (ERR pin transitions from L to H), use the steps that follow to set this configuration:

1. Set the WD_EN bit to 0.
2. Enter CSM Mode
4. Exit CSM Mode.
5. Configure the remaining SPI registers.

2.1.2 Running the Watchdog

2.1.2.1 Watchdog Startup

The watchdog timing window and logic begins when the WD_EN is set to 1 while the device is in the DIAGNOSTIC state. The WD_FAIL_CNT counter value changes depending on the answers received.

When the DIAG_EXIT_MASK bit is set, the device transitions from the DIAGNOSTIC state to the ACTIVE state when the WD_FAIL_CNT counter value is below the programmed WD_FAIL_DEFAULT[2:0] value.

When the device transitions to the ACTIVE state, the WD_FAIL_CNT counter is reset to the programmed WD_FAIL_DEFAULT[2:0] value.

Figure 8 shows this behavior in the case that the WD_FAIL_DEFAULT[2:0] bit is programmed to the default value, and the DIAG_EXIT_MASK bit is set before the first transaction completes. After the first successful watchdog transaction, the WD_FAIL_CNT counter decrements which satisfies the condition to transition to the ACTIVE state. This transition resets the WD_FAIL_CNT counter to the WD_FAIL_DEFAULT[2:0] value.
2.1.2.2 **MCU Response Calculation**

Depending on the level of coverage required by the system, the MCU can be configured to either look up a precalculated response to a generated token, or to use the internal ALU to calculate the response.

For the arithmetic required for the MCU to perform, refer to the *DRV3205-Q1 Three-Phase Automotive Gate Driver With Three Integrated Current Shunt Amplifiers and Enhanced Protection, Diagnostics, and Monitoring*.

If this level of coverage is not required, a simpler lookup table approach can be used. By storing the precalculated answer values, the MCU can provide the answer to the DRV3205-Q1 device simply by using the token value and response number to look up the answer. For more information on the stored watchdog responses, refer to the *DRV3205-Q1 Three-Phase Automotive Gate Driver With Three Integrated Current Shunt Amplifiers and Enhanced Protection, Diagnostics, and Monitoring*.

The following pseudo code written in C format illustrates how this can be implemented:

```c
static const uint8_t DRV3205_WDT_TABLE[16][4] = {
  {0xFF, 0x0F, 0xF0, 0x0},
  {0xB0, 0x40, 0xBF, 0x4F},
  {0xE9, 0x19, 0xE6, 0x16},
  {0xA6, 0x56, 0xA9, 0x59},
  {0x75, 0x85, 0x7A, 0x8A},
  {0x3A, 0xCA, 0x35, 0xC5},
  {0x63, 0x93, 0x6C, 0x9C},
  {0x2C, 0xDC, 0x23, 0xD3},
  {0xD2, 0x22, 0xD0, 0x2D},
  {0x9D, 0x6D, 0x92, 0x62},
  {0xC4, 0x34, 0xCB, 0x3B},
  {0x8B, 0x7B, 0x84, 0x74},
  {0x58, 0xA8, 0x57, 0xA7},
  {0x17, 0xE7, 0x18, 0xE8},
  {0x4E, 0xBE, 0x41, 0xB1},
  {0x01, 0xF1, 0x0E, 0xFE}
};
```

By storing the table in memory in this configuration, the answer can be accessed as follows:

```
DRV3205_WDT_TABLE[Token][ResponseNumber]
```
2.1.2.3  **Response Scheduling**

To stay synchronized with the watchdog timer, the MCU must schedule responses in the proper timing windows. This scheduling is typically implemented using a timer interrupt or inside a critical looping code section which has a strict timing requirement.

The response schedule can be done in multiple ways, as long as it satisfies the proper window timings. The recommended method of response scheduling is to use a method with a fixed period, $T$, in the MCU with a window timing set as shown in **Equation 2**.

\[
T = \left[ (RT[6:0]+1) + ((RW[4:0]+1) \times 0.5) \right] \times 0.55\text{ms}
\]  

(2)

At each period, $T$, the MCU writes the fourth response in the middle of the close window which triggers the end of the watchdog sequence and the beginning of a new open window. Immediately after the fourth response, the token is queried, the answers are calculated, and the first three responses are sent. The WDT_WIN2_CFG time should be set to the allowable variation in the MCU loop timing.

![Figure 9. Watchdog Response Scheduling](image)

2.1.2.4  **Resynchronizing the Watchdog Timer**

In the case that the MCU no longer captures the correct timing, the MCU must resynchronize with the internal timing of the DRV3205-Q1 device. The device provides functionality to help with resynchronizing. The functionality is listed as follows:

- Stop existing timing and response generation in the MCU.
- Clear the TIME_OUT flag to 0 by writing a dummy value to the WDT_WINx_CFG register.
- Poll the TIME_OUT flag for a transition from 0 to 1.
- Reset the MCU timer to this transition.
- Run the watchdog routine normally and verify that the WD_FAIL_CNT counter value is decremented.
- Clear the WD_FAIL flag.
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